



ISSN No. : 2321-9653

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IJRASET is indexed with Crossref for DOI-DOI : 10.22214

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Volume 7, Issue V, May 2019*

*in
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Parametric Optimization of EDM of EN-40 for MRR, TWR and White Layer Thickness*

*by
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*after review is found suitable and has been published in
Volume 7, Issue V, May 2019*

*in
International Journal for Research in Applied Science &
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